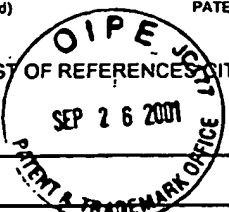


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 205525US2		SERIAL NO. NEW APPLICATION	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Shinzo OHKUBO, et al.			
				FILING DATE HEREWITH		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
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	AD						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES                  NO		
RSD	AO	2000-138632	05/16/00	JAPAN (with English Abstract)		X	
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner <i>Royd Lee</i>					Date Considered 5/20/05		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

 35971 U.S. PTO  
 09/02/05

04/05/01

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 205525US2		SERIAL NO. 09/825,952	
LIST OF REFERENCES CITED BY APPLICANT 				APPLICANT Shinzo OHKUBO, et al.			
				FILING DATE April 5, 2001		GROUP 2681	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
RSD	AA	5,794,157	08/11/98	J. C. HAARTSEN.			
RSD	AB	5,881,368	03/09/99	M. S. GROB, et al.			
	AC						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
RSD	AO	0 986 276	03/15/2000	EUROPE			
	AP						
	AQ						
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	AU						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
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Examiner <i>Byrd</i>					Date Considered <i>1/28/04</i>		

\*Examiner: Initial reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449  
(Modified)DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

205525US90

SERIAL NO.

09/825,952

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Shinzo OHKUBO, et al.

FILING DATE

April 5, 2001

GROUP

2684

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
RSD	AO	6-326691	11/25/1994	JAPAN (with English Abstract)		X
RSD	AP	8-8817	01/12/1996	JAPAN (with English Abstract)		X
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW		
	AX		
	AY		
	AZ		<input type="checkbox"/> Additional References sheet(s) attached

Examiner

Date Considered

5/20/05

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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Technology Center 2800

Form PTO 1449  
(Modified)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.  
205525US2

SERIAL NO.  
09/825,952

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT  
Shinzo OHKUBO, et al.

FILING DATE  
April 5, 2001

GROUP  
2681

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
RSD	AA	5,386,589	01/31/95	T. KANAI			
	AB						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
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RSD	AO	1999-009542	02/05/99	KOREA		X
	AP					
	AQ					
	AR					
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

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	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner *Raymond L. Du*

Date Considered *1/28/04*

\*Examiner: Initial reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

**CORRECTED**

SHEET 1 OF 1

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

205525US2

SERIAL NO.

09/825,952

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Shinzo OHKUBO, et al.

FILING DATE

April 5, 2001

GROUP

2681

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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**RECEIVED**  
FEB 20 2003  
Technology Center 2600

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
RSO	AO	1235718	03/19/98	CHINA (with English Abstract)		X
RSO	AP	1120293	04/10/96	CHINA (with English Abstract)		X
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

Date Considered 5/20/05

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